



Power MOSFETS

DATASHEET

LM40095PAN3A

P-Channel
Enhancement Mode MOSFET

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Quality Management Systems
ISO 9001:2015 Certificate

LM40095PAN3A

P-Channel Enhancement Mode MOSFET

Pin Description

TO-251-3L (TOP view)	Symbol	Symbol	P-Channel	Unit
		V_{DSS}	-40	V
		$R_{DS(ON)-Max}$	10.6	$m\Omega$
		I_D	-77	A

Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested

Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM40095PAN3A	TO-251-3L	Tube	75 / Tube	40095 <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/>

Note : = Lot Code

Absolute Maximum Ratings ($T_J=25^\circ C$ Unless Otherwise Noted)

Symbol	Parameter	P-Channel	Unit
V_{DSS}	Drain-Source Voltage	-40	V
V_{GSS}	Gate-Source Voltage	± 20	
T_J	Maximum Junction Temperature	150	$^\circ C$
T_{STG}	Storage Temperature Range	-55 to 150	$^\circ C$
I_S	Diode Continuous Forward Current	$T_c=25^\circ C$	-57
$I_{DM}^{(1)}$	Pulse Drain Current Tested	$T_c=25^\circ C$	-192
I_D	Continuous Drain Current	$T_c=25^\circ C$	-77
		$T_c=100^\circ C$	-49
P_D	Maximum Power Dissipation	$T_c=25^\circ C$	62.5
		$T_c=100^\circ C$	25
I_D	Continuous Drain Current	$T_A=25^\circ C$	-13.7
		$T_A=70^\circ C$	-11
P_D	Maximum Power Dissipation	$T_A=25^\circ C$	2.0
		$T_A=70^\circ C$	1.3
$I_{AS}^{(2)}$	Avalanche Current, Single pulse	$L=0.1mH$	-30
		$L=0.5mH$	-15
$E_{AS}^{(2)}$	Avalanche Energy, Single pulse	$L=0.1mH$	45
		$L=0.5mH$	56

Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	2 $^\circ C/W$
$R_{\theta JA}^{(3)}$	Thermal Resistance-Junction to Ambient	Steady State	62.5 $^\circ C/W$

Note ① : Max. current is limited by junction temperature

Note ② : UIS tested and pulse width are limited by maximum junction temperature 150°C

Note ③ : Surface Mounted on 1in² FR-4 board with 1oz.

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P-Channel Electrical Characteristics ($T_J=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
Static Electrical Characteristics						
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}, I_{\text{DS}}=-250\mu\text{A}$	-40	-	-	V
I_{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}}=-32\text{V}, V_{\text{GS}}=0\text{V}$	-	-	-1	μA
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}, I_{\text{DS}}=-250\mu\text{A}$	-1.1	-1.7	-2.3	V
I_{GSS}	Gate Leakage Current	$V_{\text{GS}}=\pm 20\text{V}, V_{\text{DS}}=0\text{V}$	-	-	± 100	nA
$R_{\text{DS(ON)}}^{\circledast}$	Drain-Source On-state Resistance	$V_{\text{GS}}=-10\text{V}, I_{\text{DS}}=-12\text{A}$	-	8.8	10.6	$\text{m}\Omega$
		$V_{\text{GS}}=-4.5\text{V}, I_{\text{DS}}=-9\text{A}$	-	10.4	14	
g_{fs}	Forward Transconductance	$V_{\text{DS}}=-5\text{V}, I_{\text{DS}}=-6\text{A}$	-	22	-	S
Dynamic Characteristics [®]						
R_{G}	Gate Resistance	$V_{\text{GS}}=0\text{V}, V_{\text{DS}}=0\text{V},$ $\text{Freq.}=1\text{MHz}$	-	8	-	Ω
C_{iss}	Input Capacitance	$V_{\text{GS}}=0\text{V},$ $V_{\text{DS}}=-20\text{V},$ $\text{Freq.}=1\text{MHz}$	-	3853	-	pF
C_{oss}	Output Capacitance		-	336	-	
C_{rss}	Reverse Transfer Capacitance		-	226	-	
$t_{\text{d(ON)}}$	Turn-on Delay Time	$V_{\text{GS}}=-10\text{V}, V_{\text{DS}}=-25\text{V},$ $I_{\text{D}}=-1\text{A}, R_{\text{GEN}}=6\Omega$	-	6.4	-	nS
t_{r}	Turn-on Rise Time		-	18.1	-	
$t_{\text{d(OFF)}}$	Turn-off Delay Time		-	177	-	
t_{f}	Turn-off Fall Time		-	92	-	
Q_{g}	Total Gate Charge	$V_{\text{GS}}=-4.5\text{V}, V_{\text{DS}}=-20\text{V}$ $I_{\text{D}}=-12\text{A}$	-	40.8	-	nC
Q_{g}	Total Gate Charge	$V_{\text{GS}}=-10\text{V}, V_{\text{DS}}=-20\text{V},$ $I_{\text{D}}=-12\text{A}$	-	85.8	-	
Q_{gs}	Gate-Source Charge		-	16.8	-	
Q_{gd}	Gate-Drain Charge		-	12.7	-	
Source-Drain Characteristics						
$V_{\text{SD}}^{\circledast}$	Diode Forward Voltage	$I_{\text{SD}}=-6\text{A}, V_{\text{GS}}=0\text{V}$	-	-0.75	-1.1	V
t_{rr}	Reverse Recovery Time	$I_{\text{F}}=-6\text{A}, V_{\text{R}}=-20\text{V}$	-	24.8	-	nS
Q_{rr}	Reverse Recovery Charge	$dI_{\text{F}}/dt=100\text{A}/\mu\text{s}$	-	17.4	-	nC

Note ④ : Pulse test (pulse width $\leq 300\mu\text{s}$, duty cycle $\leq 2\%$).

Note ⑤ : Guaranteed by design, not subject to production testing.

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P-Channel Typical Characteristics

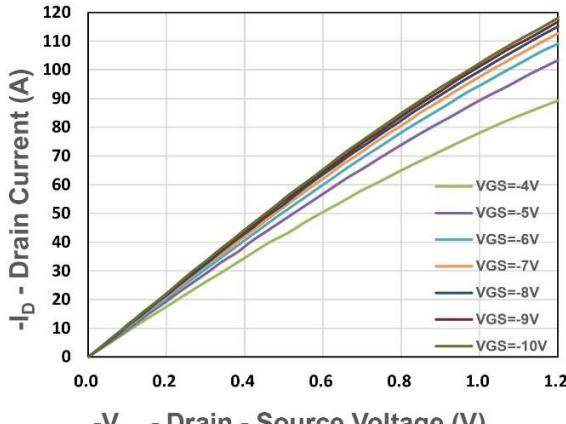


Figure 1. Output Characteristics

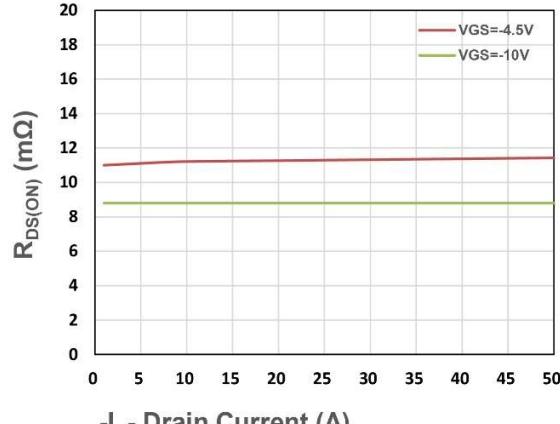


Figure 2. On-Resistance vs. ID

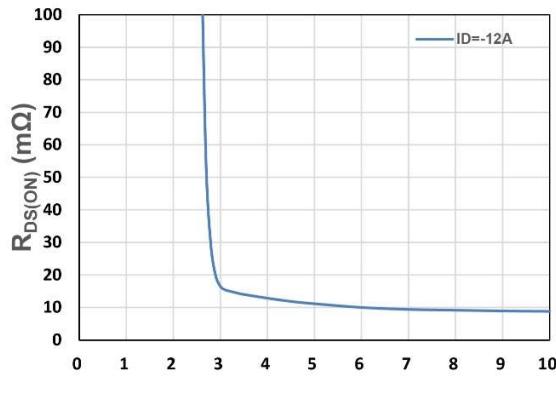


Figure 3. On-Resistance vs. VGS

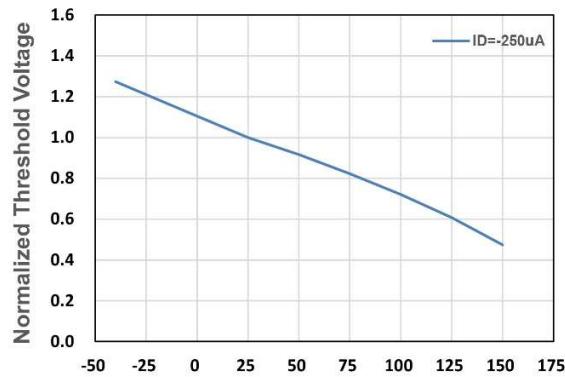


Figure 4. Gate Threshold Voltage

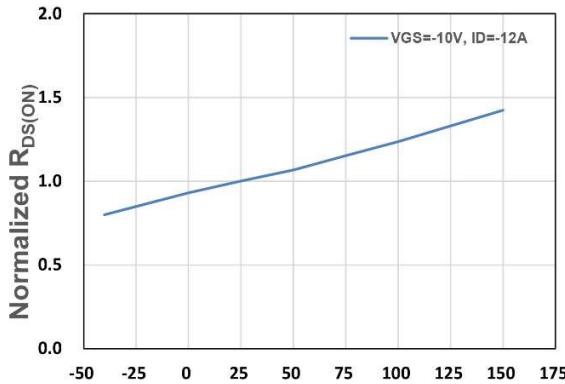


Figure 5. Drain-Source On Resistance

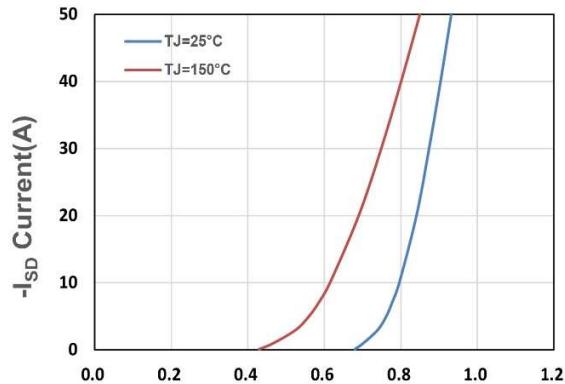
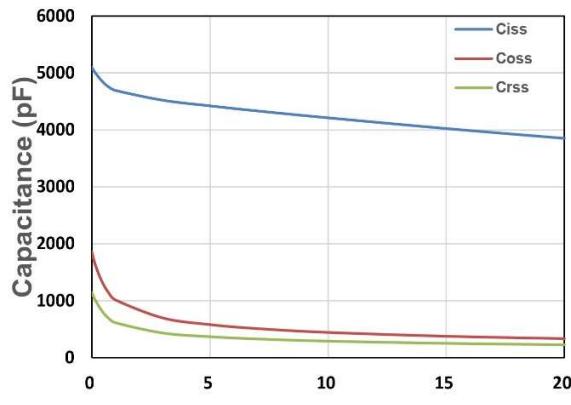
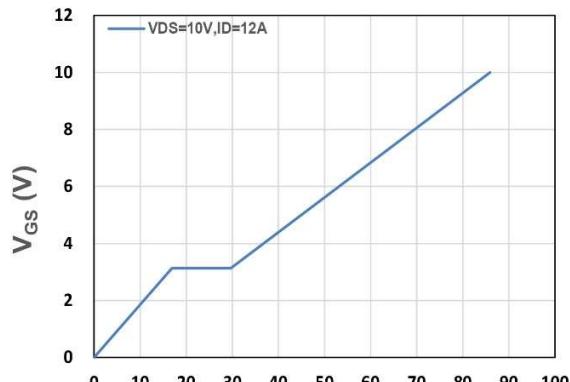


Figure 6. Source-Drain Diode Forward

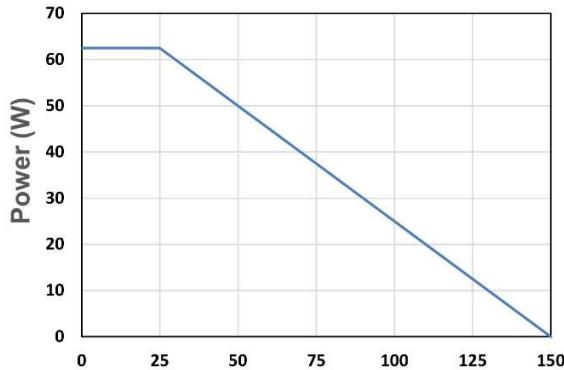
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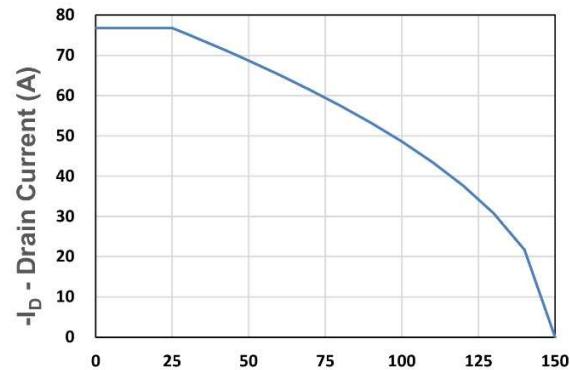
$-V_{DS}$ - Drain - Source Voltage (V)
Figure 7. Capacitance



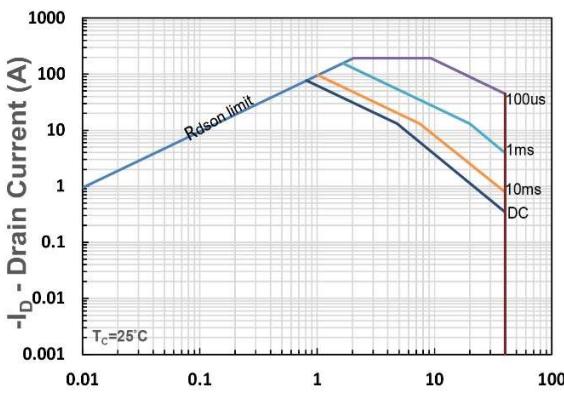
Q_g , Total Gate Charge (nC)
Figure 8. Gate Charge Characteristics



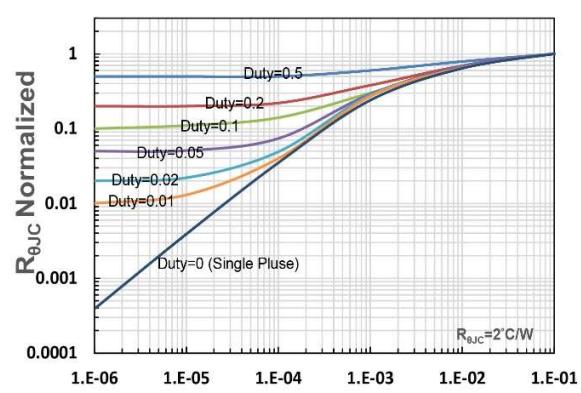
T_c - Case Temperature (°C)
Figure 9. Power Dissipation



I_D - Drain Current (A)
Figure 10. Drain Current



$-V_{DS}$ - Drain-Source Voltage (V)
Figure 11. Safe Operating Area



t_1 , Square Wave Pulse Duration(s)
Figure 12. $R_{\theta,JC}$ Transient Thermal Impedance